TC5070P, TC5071P, TC5072P

C²MOS DIGITAL INTEGRATED CIRCUIT
SILICON MONOLITHIC

## TC5070P/TC5071P/TC5072P   6 DIGIT UNIVERSAL COUNTER

TC5070P/TC5071P/TC5072P are 6-digit universal counter containing 6-digit memory register in addition to functions of up/down counting, data presetting, zero suppress, and latch.

The counted contents are output in BCD and seven segment dynamically stepwise from most significant digit in synchronization with input of SCAN.

The seven-segment output can directly drive the common cathode type LED.

In addition to CARRY and ZERO outputs, these counter are provided with EQUAL output, permitting a wide range of applications such as for measuring instruments, timers, etc.
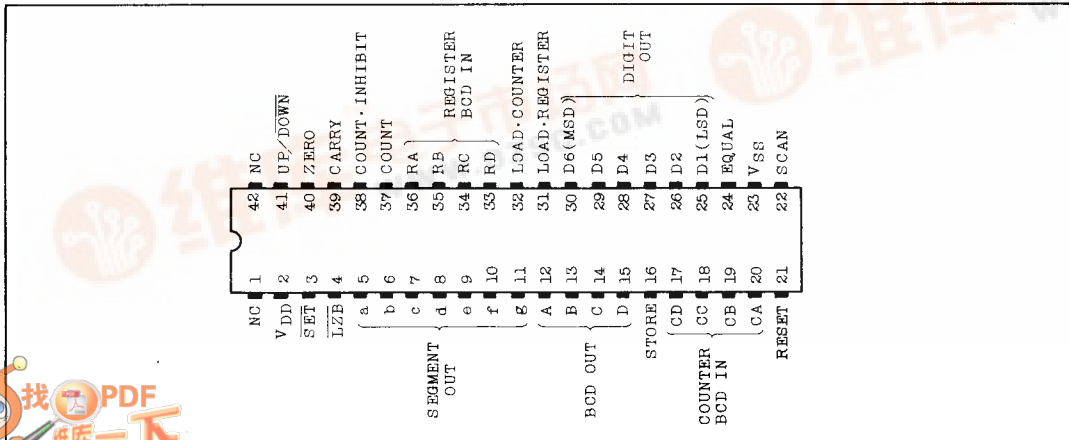
    Maximum counting value
    TC5070P 999999 COUNTER
    TC5071P 995959 TIMER
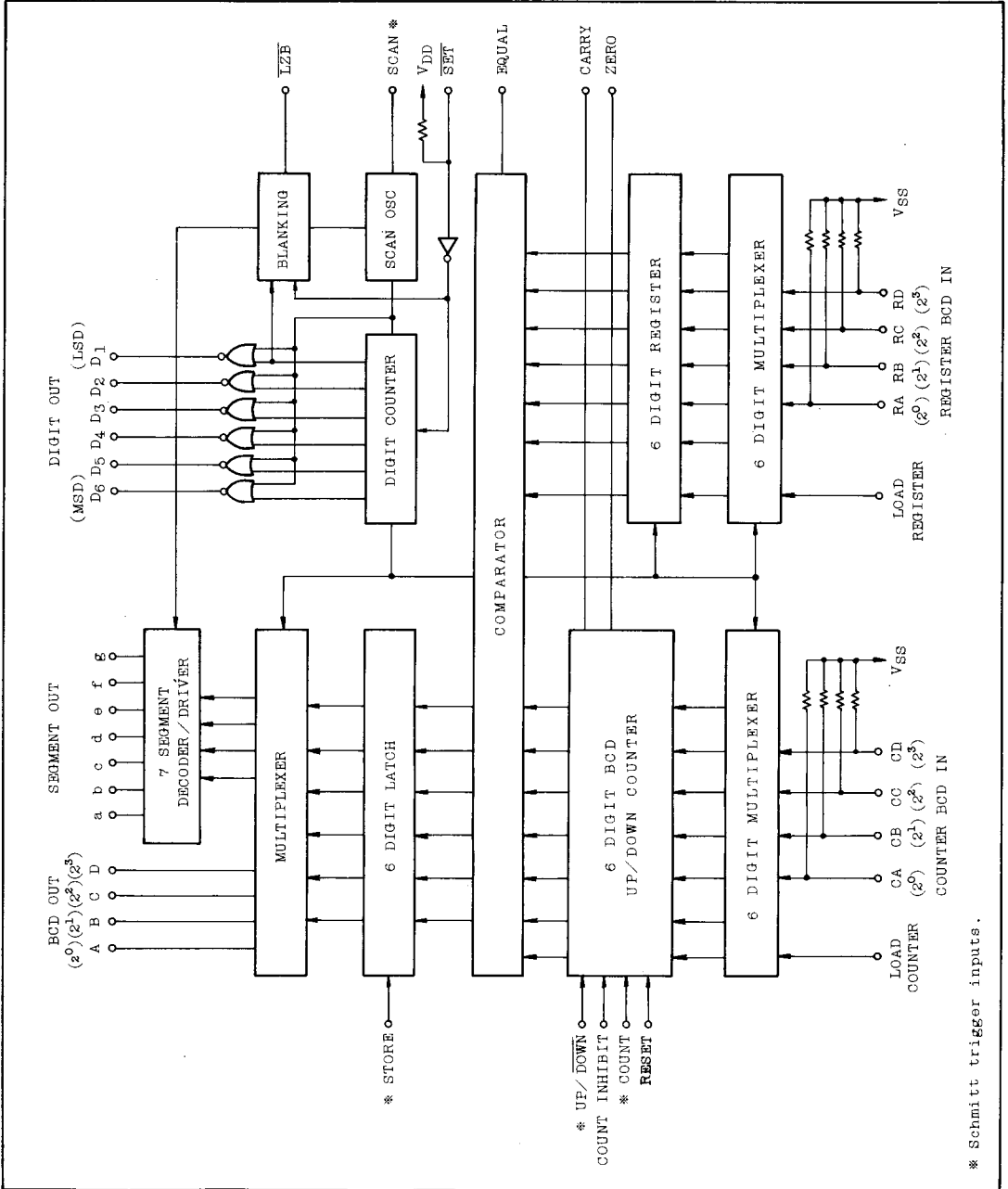   TC5072P 595999 TIMER

DIP 42 (6D42A-P)
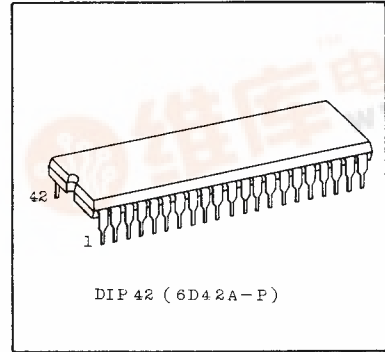
ABSOLUTE MAXIMUM RATINGS

CHARACTERISTIC	SYMBOL	RATING	UNIT
DC Supply Voltage	V_{DD}	$V_{SS}-0.5 \sim V_{SS}+10$	V
Input Voltage	V_{IN}	$V_{SS}-0.5 \sim V_{DD}+0.5$	V
Output Voltage	V_{OUT}	$V_{SS}-0.5 \sim V_{DD}+0.5$	V
DC Input Current	I_{IN}	± 10	mA
Power Dissipation	P_D	300	mW
Storage Temperature Range	T_{stg}	$-65 \sim 150$	°C
Lead Temp./Time	T_{sol}	260°C · 10sec	

PIN ASSIGNMENT

BLOCK DIAGRAM

$\overline{LZB}$ SCAN ✻ V_{DD} $\overline{SET}$ EQUAL CARRY ZERO

BLANKING

SCAN OSC

DIGIT COUNTER

6 DIGIT REGISTER

6 DIGIT MULTIPLEXER

V_{SS}

RA RB RC RD
$(2^0)(2^1)(2^2)(2^3)$
REGISTER BCD IN

LOAD REGISTER

DIGIT OUT
(MSD) D_6 D_5 D_4 D_3 D_2 D_1 (LSD)

COMPARATOR

SEGMENT OUT
g f e d c b a

7 SEGMENT DECODER / DRIVER

MULTIPLEXER

6 DIGIT LATCH

6 DIGIT BCD UP / DOWN COUNTER

6 DIGIT MULTIPLEXER

V_{SS}

CA CB CC CD
$(2^0)(2^1)(2^2)(2^3)$
COUNTER BCD IN

LOAD COUNTER

BCD OUT
$(2^0)(2^1)(2^2)(2^3)$
A B C D

✻ STORE

✻ UP / $\overline{DOWN}$
COUNT INHIBIT
✻ COUNT
$\overline{RESET}$

✻ Schmitt trigger inputs.

DESCRIPTION OF PIN FUNCTION

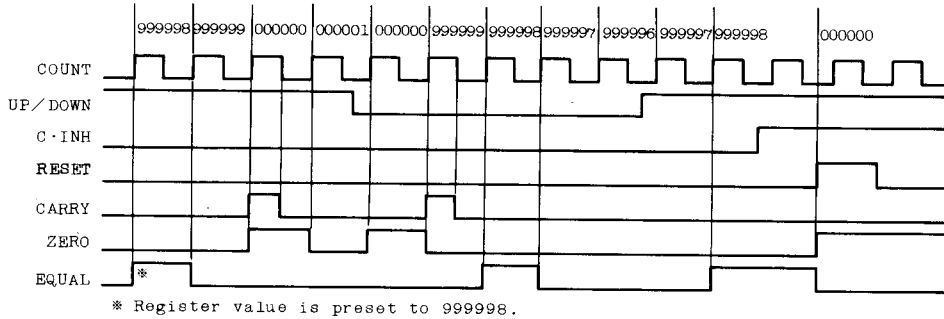| PIN No.	SYMBOL	FUNCTION	
1	NC	No connection	
2	V_{DD}	V_{DD} power supply (3-8V)	
3	$\overline{SET}$	At "L" level, the digit counter is reset, and D6 (MSD) only provide. The Segment-out changes to the blanking state. At "H" level, normal display operation.	
4	$\overline{LZB}$	"H"	No zero blanking
		"L"	Leading zero blanking in the higher order 5 digits.
5	a	Each pin is seven segment output of 6-digit counter. The output is synchronized with the digit-out and is provided stepwise from the most significant digit.	
6	b		
7	c		
8	d		
9	e		
10	f		
11	g		
12	A	Each pin is BCD output of 6-digit counter. The output is synchronized with the digit-out and is provided stepwise from the most significant digit. When $\overline{SET}$ input is at "L" level, the most significant digit data is provided.	
13	B		
14	C		
15	D		
16	STORE	"H"	At positive edge of the STORE input, the contents of the counter are latched.
		"L"	The contents of the counter are straight transferred to the miltiplexer.
17	CD	BCD input at the time when data are preset to the 6-digit counter. (With the LOAD COUNTER input at "H" level.)	
18	CC		
19	CB		
20	CA		
21	RESET	At "H" level, the 6-digit counter is reset, and the contents of the counter become ALL "0". ZERO output become at "H" level.	
22	SCAN	Auto scan oscillator is operated by connecting a capacitor (2000-20000pF) between No.22 (SCAN) and No.23 (V_{SS}) terminals. External scan oscillator may also be used to drive the scan input.	
23	V_{SS}	GND (0V)	

DESCRIPTION OF PIN FUNCTION (Cont'd)

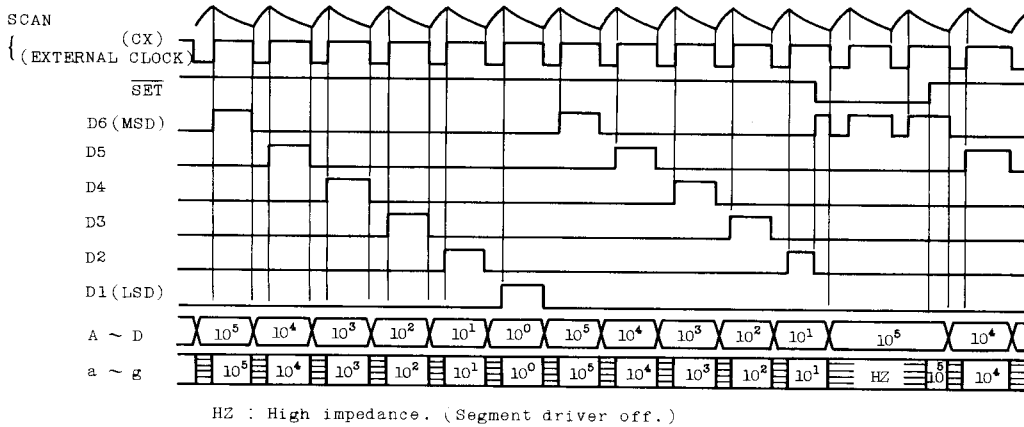| PIN No.	SYMBOL	FUNCTION	
24	EQUAL	When the contents of the 6-digit register set by the input of RA, RB, RC, and RD coincide with the contents of 6-digit counter, EQUAL output is provided at "H" level. Even if both the contents coincide each other during setting by the inputs of LOAD REGISTER and LOAD COUNTER, the output is inhibited and "L" level remains unchanged.	
25	D1(LSD)	These are the outputs to display the digits of segment out and BCD-out. When $\overline{SET}$ input reaches "L" level, the digit counter is reset and D6 (MSD) only is provided. When $\overline{SET}$ input rises at "H" level, the output is provided in the order of D5, D4...in synchronization with the SCAN clock.	
26	D2		
27	D3		
28	D4		
29	D5		
30	D6(MSD)		
31	LOAD·REGISTER (LOAD·R)	"H"	RA ~ RD input is set to 6-digit register.
		"L"	Write operation to the register is inhibited.
32	LOAD·COUNTER (LOAD·C)	"H"	CA ~ CD input is preset to the 6-digit counter.
		"L"	Write operation to the counter is inhibited.
33	RD	BCD input at the time when the data are set to the 6-digit register. (With the LOAD REGISTER input at "H" level.)	
34	RC		
35	RB		
36	RA		
37	COUNT	Clock input of 6-digit counter (Counting at the positive edge of clock)	
38	COUNT·INHIBIT (C·INH)	"H"	No counting
		"L"	Counting
39	CARRY	When the contents of counter have become "000000" at time of up-counting, CARRY output is provided at "H" level during this time from rise to fall of COUNT input. When the contents of counter have become "999999" (for TC5070P), "995959" (for TC5071P), and "595999" (for TC5072P) at time of down-counting, CARRY output is also provided at "H" level during this time from rise and fall of COUNT input.	
40	ZERO	When the contents of counter have become "00000", ZERO is provided at "H" level. During presetting by the LOAD COUNTER input, output operation is inhibited and "L" level remains unchanged.	
41	UP/DOWN	"H"	Up count.
		"L"	Down count.
42	NC	No connection.	

TC5070P, TC5071P, TC5072P

TIMING CHART

6 DIGIT COUNTER TIMING CHART (TC5070P); LOAD·C, LOAD·R="L"

999998 999999 000000 000001 000000 999999 999998 999997 999996 999997 999998 000000

COUNT
UP/DOWN
C·INH
RESET
CARRY
ZERO
EQUAL

＊ Register value is preset to 999998.

DIGIT COUNTER TIMING CHART

SCAN { (CX) (EXTERNAL CLOCK)
SET
D6(MSD)
D5
D4
D3
D2
D1(LSD)
A ~ D
a ~ g

10^5 10^4 10^3 10^2 10^1 10^0 10^5 10^4 10^3 10^2 10^1 10^5 10^4

HZ

HZ : High impedance. (Segment driver off.)

LOAD REGISTER, LOAD COUNTER TIMING CHART

D_{n+1} D_n D_{n-1}

SCAN { (CX) (EXTERNAL CLOCK)
LOAD COUNTER, LOAD REGISTER
BCD IN

VALID

＊ : Timing where data is permitted to be written at the nth digit.

＊＊ : Timing where data is written at the nth digit.
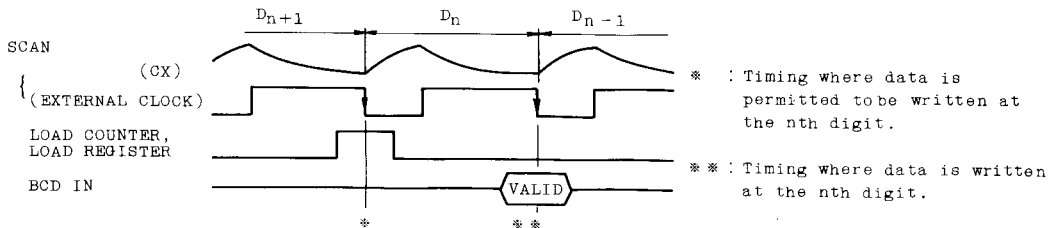
OPERATING CONSIDERATION

1. COUNTER OPERATION

    Counting is stepped by the rise of clock when the clock is added to COUNT input at
    state of the inputs of LOAD·C, C·INH, and RESET at "L" level. At time of up-
    counting, CARRY and ZERO outputs are "H" level at "000000", and at time of down-
    counting, CARRY output is at "H" level at "999999" (for TC5070P), "995959" (for
    TC5071P), and "595999: (for TC5072P).

    When CARRY output is at "H" level, CARRY output remain at "H" leve until COUNT
    input falls, even if RESET and LOAD·C inputs are changed to "H" level.

    For COUNT and UP/$\overline{\text{DOWN}}$ inputs is shaped schmitt trigger, COUNT and UP/$\overline{\text{DOWN}}$ inputs
    rarely miscounts if waveform is not sharp.

2. COMPARATOR OPERATION

    EQUAL output is provided at "H" level, when the contents of the counter coincide
    with the comparator value set by LOAD·R input. However, even if they concide each
    other during setting by LOAD·C and LOAD·R input, output operation is inhibited and
    "L" level remains unchanged.

3. LOAD COUNTER AND LOAD REGISTER OPERATIONS

    When the data required to preset the counter or when the comprating value is
    required to set to the register, such operation is made by LOAD·C and LOAD·R input.
    The presetting of data to the counter is acquired by setting LOAD.C input to "H"
    level, synchronizing CA~CD input with the digit counter, and setting the digits
    one after another. For the purpose, the external circuits are required for timing
    of D6~D1 output with CA~CD input. The comprator value can be set to the register
    in the same way. Load register operation is independently of counting operation;
    therfore, even during setting of the data to the register, counting can be
    performed. (See an example of input setting circuits.)

    (Note) that normal operation is not acquired when the data exceeding the maximum
    counting value (for each digit) shown on page 1 for the individual items are set
    to the counter and register.

4. LATCH OPERATION

    At STORE input is at "L" level, the contents of counter are straight transferred
    to the multiplexer, and the output indicates the contents of counter.

    At STORE input is at "H" level, the indicating output remains unchanged although
    the count varies for the contents of counter are latched at the positive edge of

OPERATING CONSIDERATION   (Cont'd)

STORE input. When STORE is turned to "L" level, the contents of counter at that time are provided. STORE input shape schmitt trigger.

5. DISPLAY OPERATION

At $\overline{\text{LZB}}$ input is at "L" level, the higher order 5 digits of SEGMENT-OUT output are changed to the state of leading zero blanking.

At "H" level, the function of leading zero blanking is released.

At $\overline{\text{SET}}$ input is at "L" level, the SEGMENT-OUT output is changed to the state of blanking, and the digit counter is reset, and D6 (MSD) only is provided. At that time, the BCD-OUT output provided the data of the 6th digit. At "H" level, the DIGIT-OUT output provided in the order of D6, D5, D4, ... in synchronization with SCAN, and SEGMENT-OUT and CD-OUT output are also provided in synchronization.

   Segment Display Format (Common Cathod type LED)

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    0    1    2    3    4    5    6    7    8    9   10~15
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6. SCANNING OPERATION

AUTO SCAN operation can be performed by inserting a capacitor between the terminal SCAN and the terminal V_{SS}. By adding an external clock to the terminal SCAN, MANUAL SCAN operation can be performed.

SCAN OSC actuates the digit counter, and at the AUTO SCAN operation, the digit blanking is applied to each DIGIT OUT for the T/150 period of one cycle (T) of SCAN OSC, therfore, can be prevented overlap of each DIGIT OUT. One cycle of DIGIT OUT is equal to 6 cycles of SCAN OSC.

SCAN signal synchronize with data signal setting by the LOAD REGISTER and/or LOAD COUNTER inputs. An external capacitor of 2000 to 20000pF is required for SCAN (CX).

(Note)   BCD-OUT output may involve some hazards at the change of COUNT input and DIGIT-OUT output; However, such hazards do not hinder operation because they occur during the blanking hours for DIGIT-OUT and SEGMENT-OUT output.

OPERATING CONSIDERATION (Cont'd)

SCAN OSC

$$f_{OSC} = \frac{1}{T} \ (Hz) \quad (TYP.) \ 25°C$$
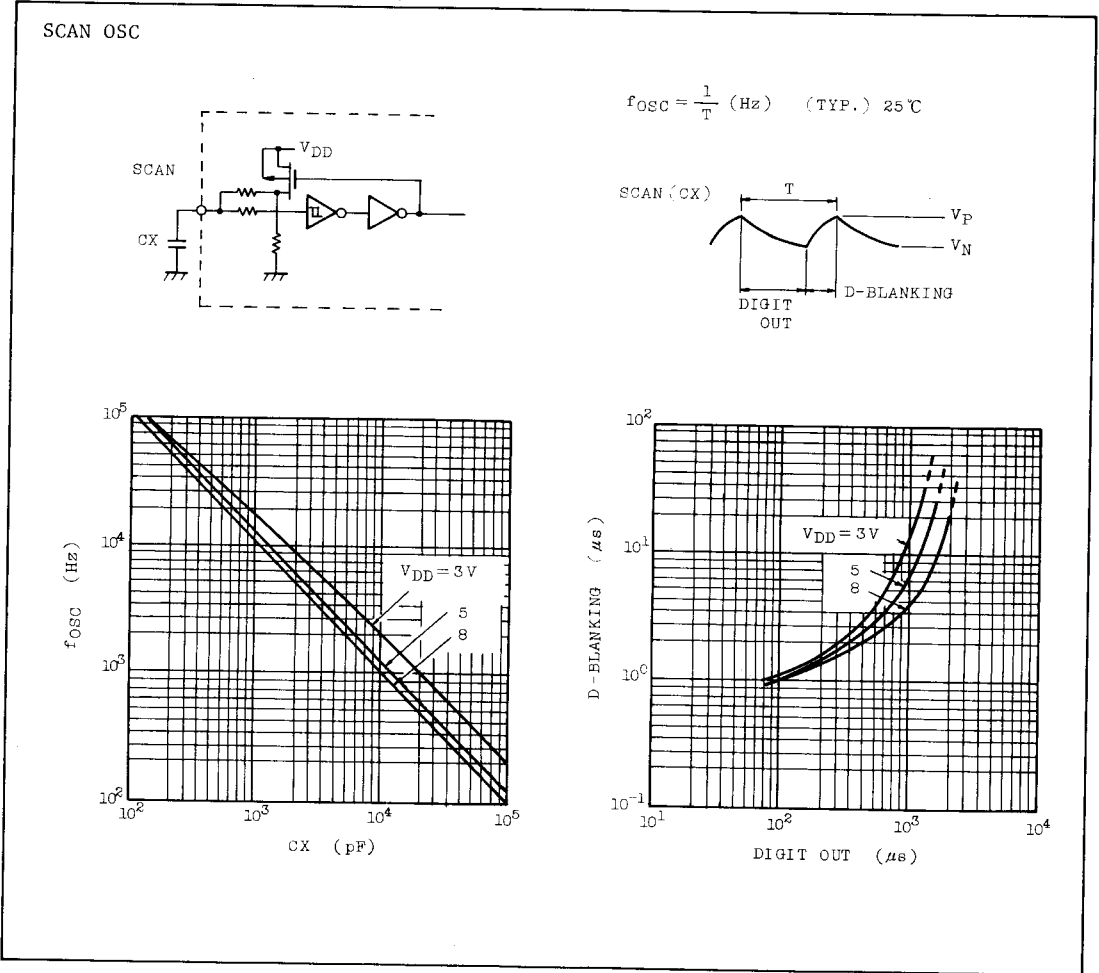
RECOMMENDED OPERATING CONDITIONS ($V_{SS}=0V$)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
DC Supply Voltage	V_{DD}		3	–	8	V
Input Voltage	V_{IN}		0	–	V_{DD}	V
Operating Temperature Range	T_{opr}		−40	–	85	°C

STATIC ELECTRICAL CHARACTERISTICS (V_{SS}=0V)

CHARACTERISTIC	SYM-BOL	TEST CONDITION	V_{DD} (V)	-40°C MIN.	-40°C MAX.	25°C MIN.	25°C TYP.	25°C MAX.	85°C MIN.	85°C MAX.	UNIT
High-Level Output Voltage (Except SEGMENT OUTPUT)	V_{OH}	$|I_{OUT}|<1\mu A$ $V_{IN}=V_{SS},V_{DD}$	5	4.95	–	4.95	5.00	–	4.95	–	V
Low-Level Output Voltage (Except SEGMENT OUTPUT)	V_{OL}	$|I_{OUT}|<1\mu A$ $V_{IN}=V_{SS},V_{DD}$	5	–	0.05	–	0.00	0.05	–	0.05	V
High-Level Output Voltage (SEGMENT OUTPUT)	V_{OH}	$|I_{OUT}|<1\mu A$ $V_{IN}=V_{SS},V_{DD}$	5	4.0	–	4.0	4.5	–	4.0	–	
Output High Current (A~D, EQ, CA, ZE OUTPUT)	I_{OH}	$V_{OH}=4.6V$ $V_{IN}=V_{SS},V_{DD}$	5	-0.2	–	-0.16	-0.8	–	-0.12	–	
Output High Current (D1~D6 OUTPUT)	I_{OH}	$V_{OH}=4.2V$ $V_{IN}=V_{SS},V_{DD}$	5	-0.75	–	-0.7	-1.5	–	-0.6	–	mA
Output Low Current (Except SEGMENT OUTPUT)	I_{OL}	$V_{OL}=0.4V$ $V_{IN}=V_{SS},V_{DD}$	5	0.52	–	0.44	1.2	–	0.36	–	
Output High Current (SEGMENT OUTPUT)	I_{OH}	$V_{OH}=3.5V$ $V_{IN}=V_{SS},V_{DD}$	5	-25	–	-25	-50	–	-20	–	
Input Low Voltage (Except Schmitt Trigger Input)	V_{IH}	$V_{OH}=4.0V$ $V_{OL}=0.5V$ $|I_{OUT}|<1\mu A$	5	3.5	–	3.5	2.75	–	3.5	–	V
Input High Voltage (Except Schmitt Trigger Input)	V_{IL}	$V_{OH}=4.0V$ $V_{OL}=0.5V$ $|I_{OUT}|<1\mu A$	5	–	1.5	–	2.15	1.5	–	1.5	
High-Level Input Current (Except Pull Up/ Down Resistance Input)	I_{IH}	$V_{IH}=8V$	8	–	0.3	–	10^{-5}	0.3	–	1.0	μA

TC5070P, TC5071P, TC5072P

DYNAMIC ELECTRICAL CHARACTERISTICS (Ta=25°C, V_{DD}=5.0V, V_{SS}=0V, C_L=50pF)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Output Transition Time (Low to High)	t_{TLH}	SEGMENT OUT (R_L=1kΩ)	–	70	200	ns
	t_{TLH}	OTHER OUT	–	100	400	
Output Transition Time (High to Low)	t_{THL}	Except SEGMENT OUT	–	70	200	
Propagation Delay Time	t_{pLH}, t_{pHL}	COUNT–BCD, SEGMENT OUT (R_L=1kΩ)	–	750	1500	
	t_{pLH}, t_{pHL}	COUNT–CARRY OUT	–	150	400	
	t_{pLH}, t_{pHL}	COUNT–ZERO OUT	–	200	400	
	t_{pLH}, t_{pHL}	COUNT–EQUAL OUT	–	270	500	
	t_{pLH}, t_{pHL}	SCAN–DIGIT OUT	–	250	500	
	t_{pLH}, t_{pHL}	SCAN–BCD OUT	–	750	1500	
Propagation Delay Time	t_{pLH}	SCAN–SEGMENT OUT (R_L=1kΩ)	–	500	1000	
	t_{pHL}	SCAN–SEGMENT OUT (R_L=1kΩ)	–	300	700	
Max. Clock Frequency	f_{CL}-1	COUNT IN ※	2.0	4.0	–	MHz
	f_{CL}-2		1.0	1.6	–	
	f_{CL}	SCAN IN	0.5	1.0	–	
Min. Pulse Width	t_W	RESET IN	–	250	500	ns
	t_W	STORE IN	–	80	160	
Min. Set-up Time	t_{SU}	COUNT–STORE	–	70	150	
	t_{SU}	COUNT–UP/$\overline{DOWN}$	–	230	500	
	t_{SU}	STORE–CLEAR	–	130	300	
	t_{SU}	COUNT–C·IN	–	0	100	
	t_{SU}	SCAN IN–LOAD·C, LOAD·R	–	-40	50	
	t_{SU}	SCAN IN–BCDIN	–	200	450	
Min. Hold Time	t_H	COUNT–UP/$\overline{DOWN}$	–	40	150	
	t_H	SCAN IN–LOAD·C, LOAD·R	–	70	200	
	t_H	SCAN IN–BCDIN	–	140	300	
Min. Removal Time	t_{rem}	COUNT–RESET	–	60	150	
Max. Input Rise/Fall Time	t_{rCL}	Except Schmitt Trigger Input	20	–	–	μs
	t_{rCL}	Except Schmitt Trigger Input	20	–	–	
Positive Trigger Threshold Voltage	V_P		—	3.0	4.0	V
Negative Trigger Threshold Voltage	V_N		1.0	1.8	–	
Hysteresis Voltage	V_H		0.5	1.2	–	

DYNAMIC ELECTRICAL CÄHRACTERISTICS (Ta=25°C, V_{DD}=5.0V, V_{SS}=0V, C_L=50pF)

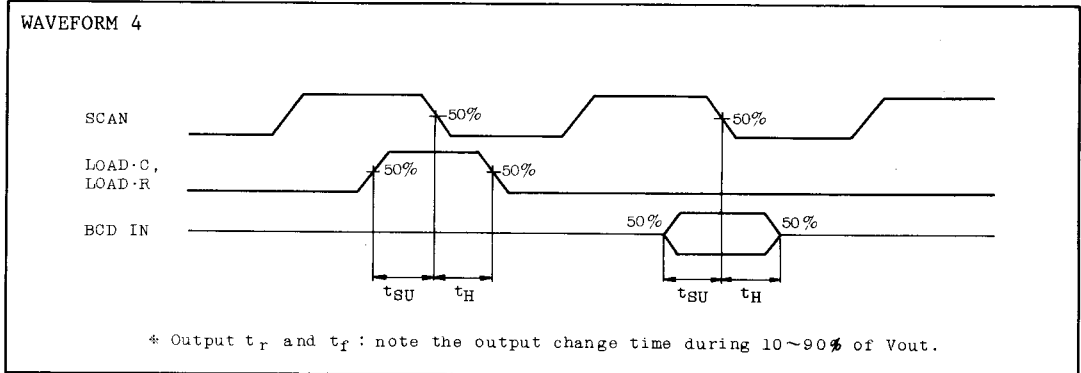| CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Quiescent Device Current (C_X=2000～20000pF)	I_{DD}	COUNT IN = H & L	–	250	–	μA
		COUNT IN = 1 MHz	–	650	–	
Input Capacitance	C_{IN}	Except SCAN IN	–	5.0	7.5	pF

* The count operation can respond as far as $f_{CL}-1$, and CARRY, EQUAL, and ZERO outputs can respond as far as $f_{CL}-2$.

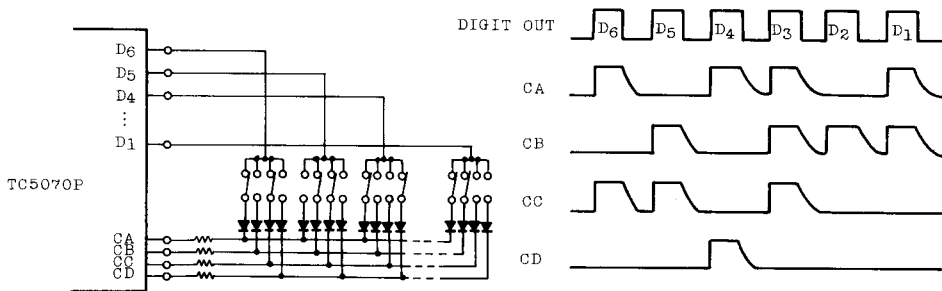WAVEFORMS FOR MEASUREMENT OF DYNAMIC CHARACTERISTICS
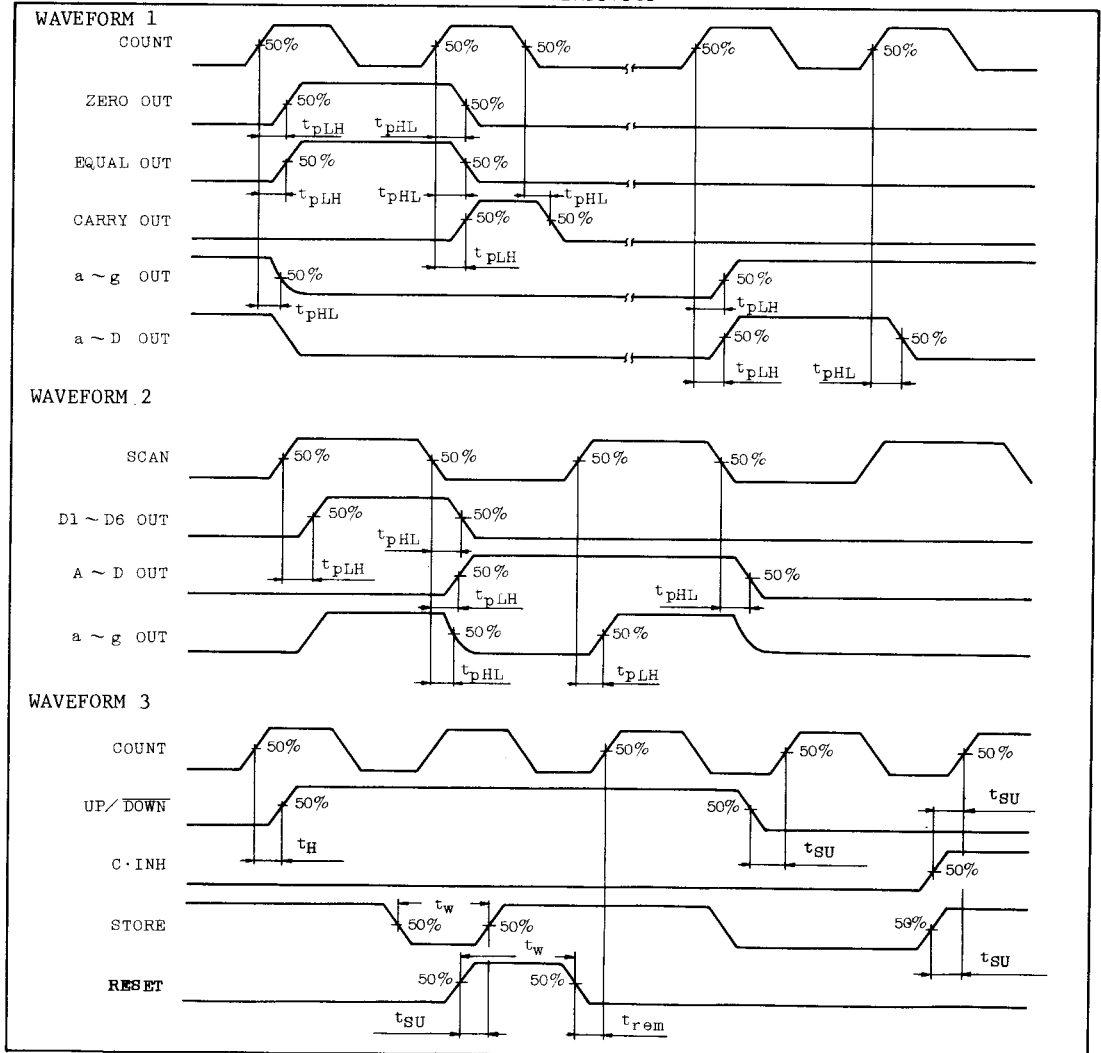
TC5070P, TC5071P, TC5072P
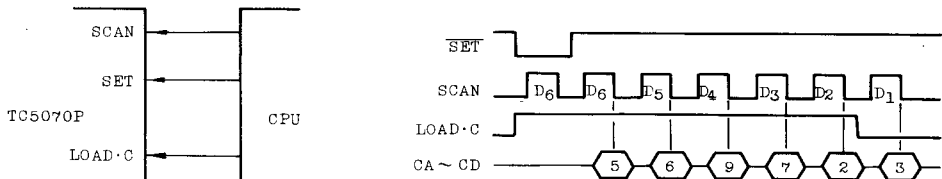
WAVEFORMS FOR MEASUREMENT OF DYNAMIC CHARACTERISTICS

WAVEFORM 4

SCAN

LOAD·C,
LOAD·R

BCD IN

t_{SU} t_H t_{SU} t_H

* Output t_r and t_f : note the output change time during 10~90% of Vout.

TYPICAL INPUT SELECT CIRCUIT

(1) IN CASE OF DATA PRESETTING WITH DIGITAL SWITCH, ETC.

TC5070P

D_6
D_5
D_4
D_1

CA
CB
CC
CD

DIGIT OUT D_6 D_5 D_4 D_3 D_2 D_1

CA

CB

CC

CD

* In case of presetting 569723

(2) IN CASE OF DATA PRESETTING WITH MICRO-COMPUTER, ETC.

TC5070P

SCAN

SET

LOAD·C

CA
CB
CC
CD

CPU

$\overline{SET}$

SCAN D_6 D_6 D_5 D_4 D_3 D_2 D_1

LOAD·C

CA ~ CD   5   6   9   7   2   3

* In case of presetting 569723

APPLICATION CIRCUIT